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Application/Control No.	Applicant(s)/Patent under Reexamination	-
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Examiner	Art Unit	
Carlos Lopez	1731	

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Class	Subclass	Date	Examiner		
65	33.5,33.6, 42,43,154, 155,152	1/23/2007	CL		
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INT	INTERFERENCE SEARCHED		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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EAST(DERWENT,USOCR,USP AT,USPGPUBS,JPO,EPO,IBM_TBD)-see search notes. EAST and EDAN inventorship search.	1/23/2007	CL
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